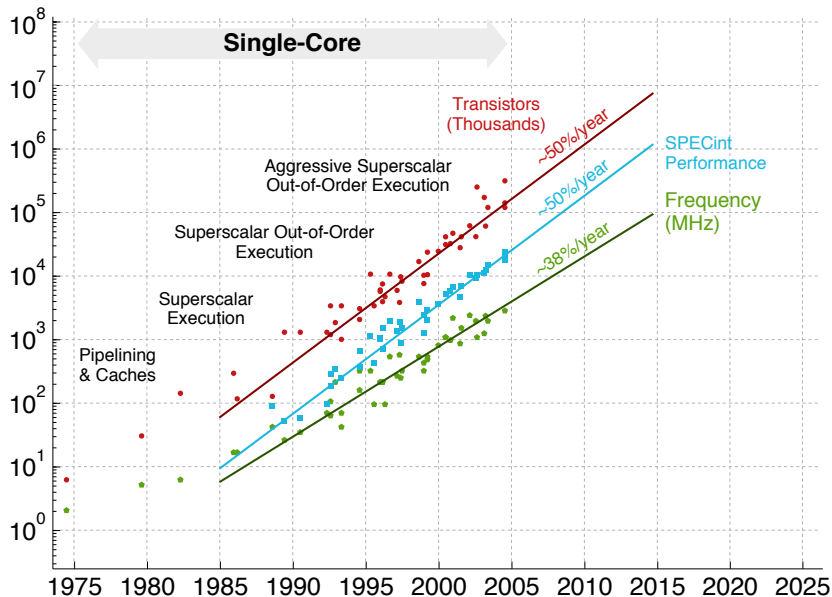


Processor Trends

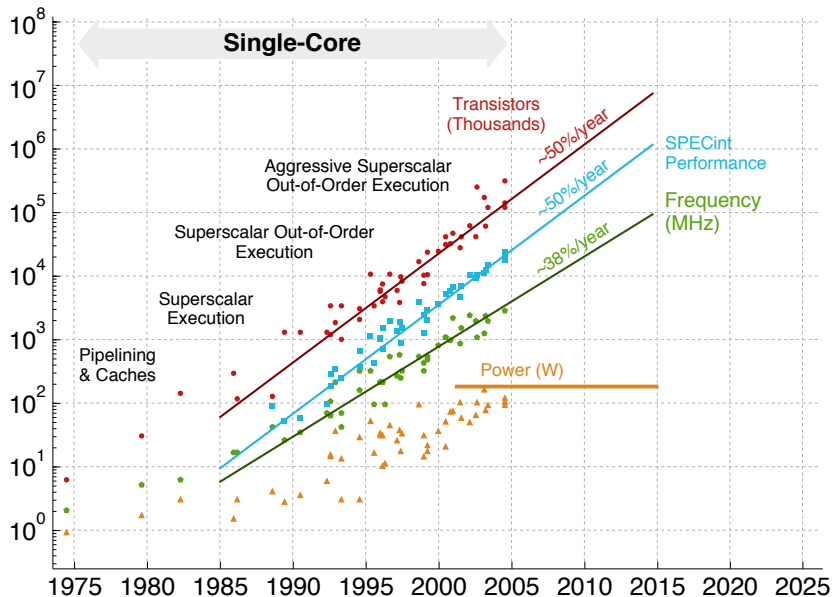
Christopher Batten

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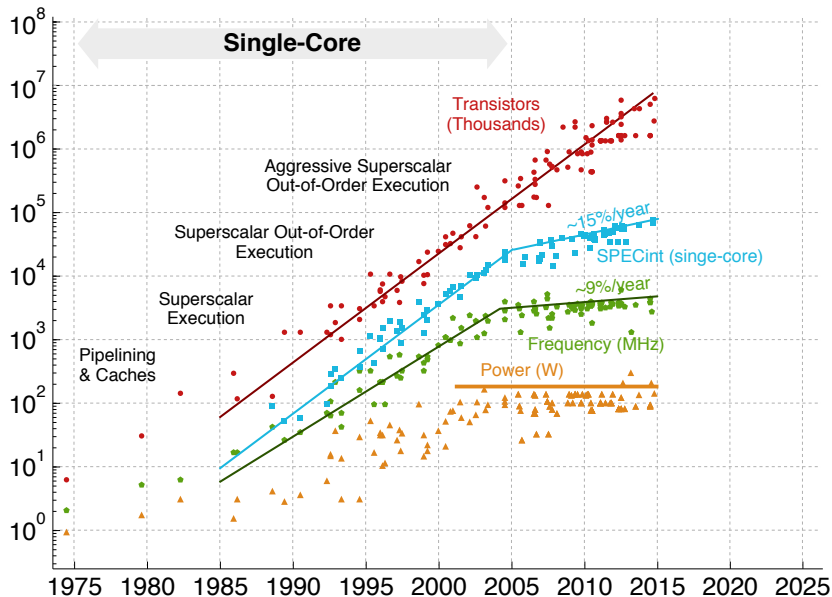
Fall 2022



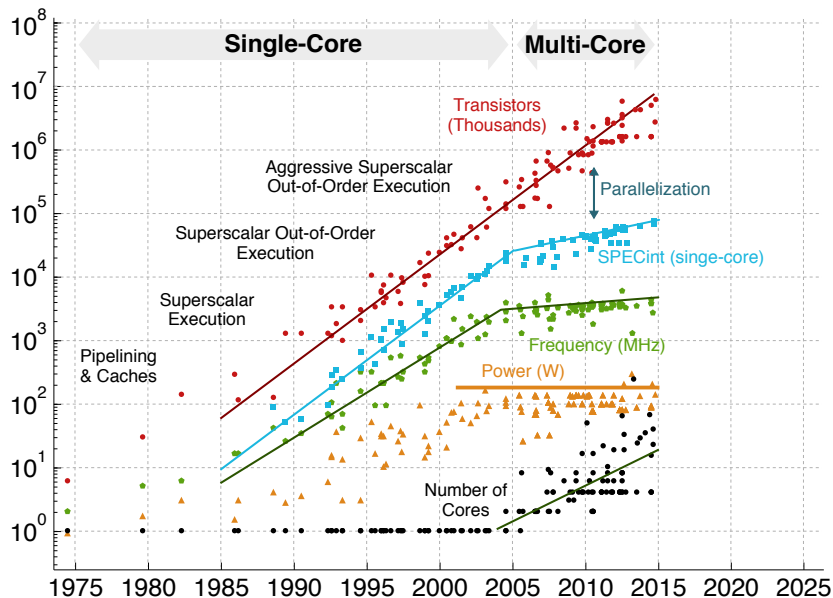
C. Batten, M. Horowitz, F. Labonte, O. Shacham, K. Olukotun, L. Hammond, K. Rupp & [Y. Shao, IEEE Micro'15] & [C. Leiserson, Science'20]



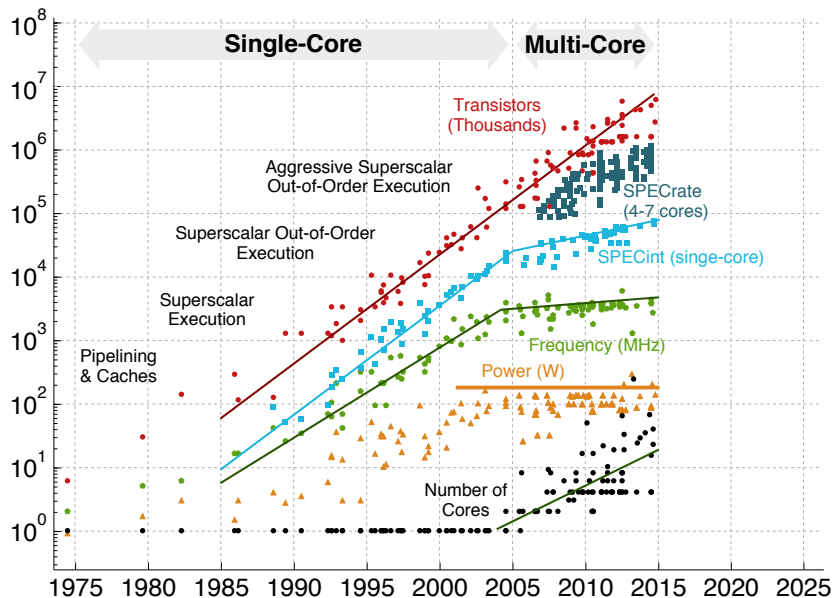
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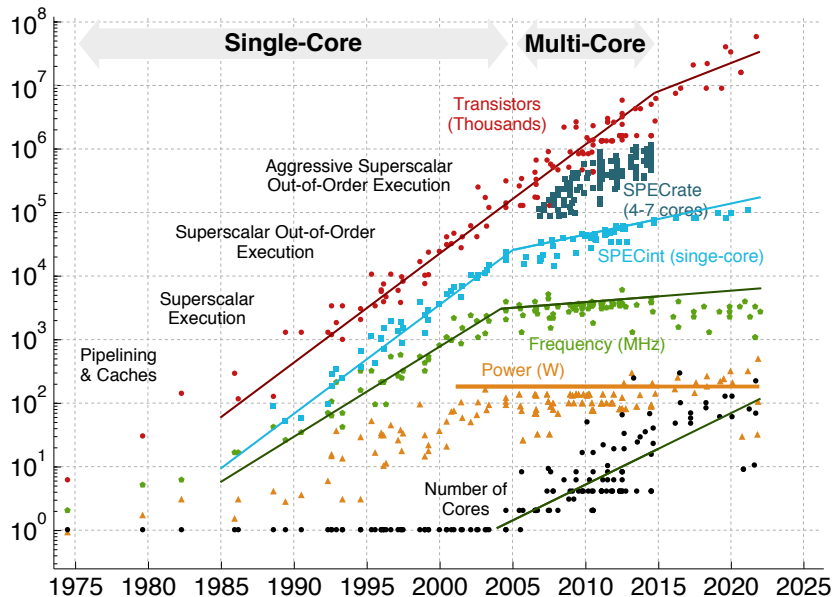
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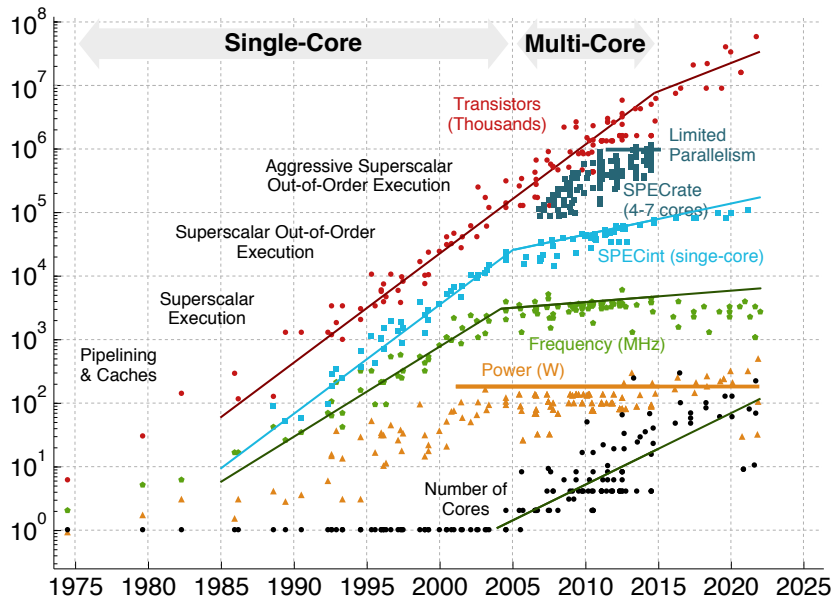
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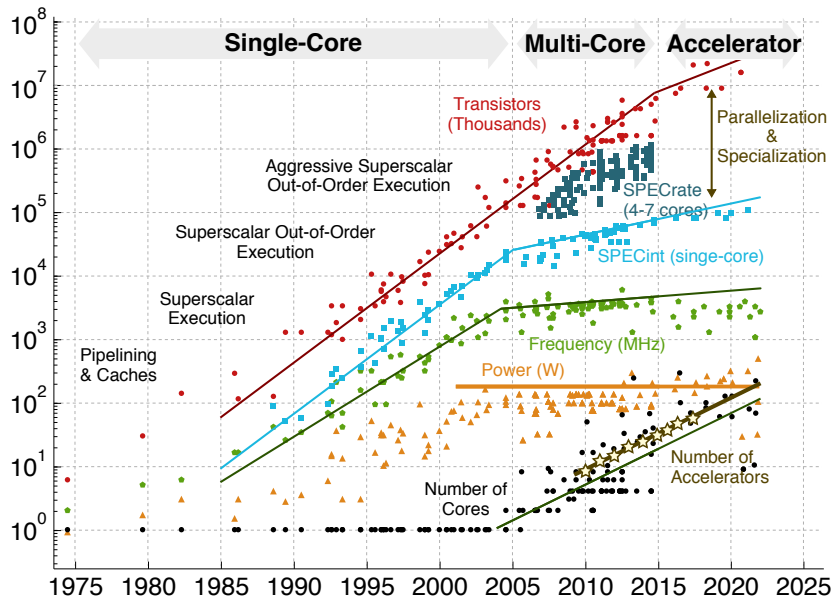
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